

<b>Notice of References Cited</b>	Application/Control No. 10/586,602		Applicant(s)/Patent Under Reexamination MURAOKA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	M	US-			

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	U	IPDL JPO Machine Translation for Uenae, JP 2004-362777, (12-2004)
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